



# IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,  
Assemblies, Related Materials and Processes

For rules and details of the IECQ visit [www.iecq.org](http://www.iecq.org)

## Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 16.0003-07

CB Certificate No.: 50600097 ITL

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### Appendix-1 (50600097 ITL)

### Schedule of Scope to Certificate of Approval

Description test	Standard
Scanning Electron Microscope (SEM)	T-SEM-3
Transmission Electron Microscope (TEM)	T-TEM-3
Focused Ion Beam microscope (FIB)	T-FIB-3
Emission Microscopy (EMMI)-InGaAs	T-EFA-3
Optical Microscope (OM)	T-OMI-3
IC Layout Imaging	T-OMI-3
Decapsulation- Chemical	T-LAB-3
Delayer	T-LAB-3
Thermal Emission Microscope (THEMOS)	T-EFA-3
Energy Dispersive Spectrometry of X-ray (EDS)	T-SEM-3, T-TEM-3
3D Optical Microscope (3D OM)	T-LAB-3

*Paul Yang*

Technical Reviewer of DQS: \_\_\_\_\_ Date: 8/29/2024

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DQS-Group - DQS Taiwan Inc., Feng Yuan Dist., Taichung City, Taiwan

